

Search Notes

Application/Control No.

10/742,306

Examiner

Junghwa M. Im

Applicant(s)/Patent under
Reexamination

SHEN ET AL.

Art Unit

2811

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST (uspat, uspub, epo, jpo, der, ibm) | 1/26/2006 | JMI |
| text search: see search history printout | 1/26/2006 | JMI |
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